

Notice of References Cited	Application/Control No. 09/730,519	Applicant(s)/Patent Under Reexamination HARRISON ET AL	
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,604,242	08-2003	Weinstein et al.	725/109
	B	US-2004/0172661	09-2004	Yagawa et al.	725/131
	C	US-2004/0103439	05-2004	Macrae et al.	725/109
	D	US-2003/0115612	06-2003	Mao et al.	725/136
	E	US-2003/0056215	03-2003	KANUNGO, RAJESH	725/38
	F	US-2002/0116718	08-2002	HARRISON et al.	725/109
	G	US-2002/0007493	01-2002	BUTLER et al.	725/109
	H	US-6,785,905	08-2004	Nishioka et al.	725/110
	I	US-6,658,662	12-2003	Nielsen, Jakob	725/109
	J	US-6,631,523	10-2003	Matthews et al.	725/53
	K	US-6,628,302	09-2003	White et al.	345/717
	L	US-6,622,306	09-2003	Kamada, Tomihisa	725/109
	M	US-6,571,392	05-2003	Zigmond et al.	725/110

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
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NON-PATENT DOCUMENTS

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,545,722	04-2003	Schultheiss et al.	348/552
	B	US-6,510,557	01-2003	Thrift, Philip R.	725/110
	C	US-6,510,558	01-2003	Iinuma et al.	725/113
	D	US-6,490,726	12-2002	Harrison et al.	725/110
	E	US-6,392,664	05-2002	White et al.	345/717
	F	US-6,367,080	04-2002	Enomoto et al.	725/112
	G	US-6,263,507	07-2001	Ahmad et al.	725/134
	H	US-6,240,555	05-2001	Shoff et al.	725/110
	I	US-6,219,042	04-2001	Anderson et al.	345/716
	J	US-6,061,719	05-2000	Bendinelli et al.	709/218
	K	US-6,061,082	05-2000	Park, Jong-Baek	725/14
	L	US-6,025,837	02-2000	Matthews et al.	345/721
	M	US-5,987,509	11-1999	Portuesi, Michael J.	725/113

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-5,982,445	11-1999	Eyer et al.	348/461
	B	US-5,907,322	05-1999	Kelly et al.	725/51
	C	US-6,124,804	09-2000	Kitao et al.	340/825.69
	D	US-5,436,676	07-1995	Pint et al.	348/734
	E	US-5,926,175	07-1999	Sturgeon et al.	345/716
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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